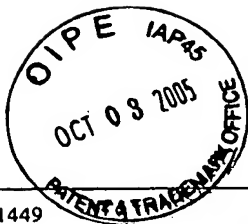


Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 118456		APPLICATION NO. New U.S. Patent Application	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Yoshiharu AJIKI et al.			
				FILING DATE February 20, 2004			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
/RH/	1	JP A 2001-113141 w/ Abst & Trans	4/24/2001	Japan			
/RH/	2	JP A 2002-298860 w/ Abst & Trans	10/11/2002	Japan			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
/RH/	3	LEE et al., "FACTORIAL DESIGN STUDY OF MINIATURE FUEL CELLS WITH MICROMACHINED SILICON FLOW STRUCTURES," The 200 th Meeting of the Electrochemical Society, Abstract No. 452, 2001.					
/RH/	4	CHANG-CHIEN et al., "PLANAR INTERCONNECTION OF MULTIPLE POLYMER ELECTROLYTE MEMBRANE FUEL CELLS BY MICROFABRICATION," The 200 th Meeting of the Electrochemical Society, Abstract No. 453, 2001.					
EXAMINER				DATE CONSIDERED			
/Robert Hodge/				05/10/2007			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 118456		APPLICATION NO. 10/781,752	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Yoshiharu AJIKI et al.			
				FILING DATE February 20, 2004		GROUP 1746	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
/RH/	1	US 2003/0013602 A12	1/16/2003	Uchida et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
/RH/	2	KR 2003-0011765A	2/11/2003	Korea			
/RH/	3	WO 02-05372 A1	1/17/2002	WIPO			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER /Robert Hodge/				DATE CONSIDERED 05/10/2007			
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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 118456		APPLICATION NO. 10781,752	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Yoshiharu AJIKI et al.			
				FILING DATE February 20, 2004		GROUP 1745	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
/RH/	1.	6,893,103 B2	05/17/2005	Okada et al.			
	2.	US 2005/0019649 A1	01/27/2005	Kakutani et al.			
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	4.	6,106,965	08/22/2000	Hirano et al.			
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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
/RH/	5.	WO 00/69007	11/16/2000	WIPO			
	6.	WO 01/70392 A1	09/27/2001	WIPO			
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	11.	JP-A-2003-229141	08/15/2003	Japan	X	X	
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	15.	JP-A-07-176317	07/14/1995	Japan	X	X	
EXAMINER /Robert Hodge/				DATE CONSIDERED 05/10/2007			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: February 26, 2007



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Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
118456APPLICATION NO.
10/781,752

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Yoshiharu AJIKI et al.FILING DATE
February 20, 2004GROUP
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Examiner Initials	Cite No.	Document Number	Date	Name
/RH/	1.	6,287,717	09-2001	Cavalca et al.

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/RH/	2.	TW 517604	11-2003	Taiwan		X
/RH/	3.	WO 02-98561	12-2002	WIPO	X	

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

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DATE CONSIDERED
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Date: April 16, 2007